

Search Notes

Application/Control No.

10/693,755

Examiner

Winnie Yip

Applicant(s)/Patent under
Reexamination

FEUCHT ET AL.

Art Unit

3636

SEARCHED

Class	Subclass	Date	Examiner
52	58 72 97 198 200	7/18/2007	WSY
↓	302.6	↓	↓
↓	712-713	↓	↓
285	42-44	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR